TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (Ultra-High-Speed U-MOSIII)

# **TPCA8016-H**

High-Speed and High-Efficiency DC-DC Converters Notebook PC Applications **Portable Equipment Applications** 

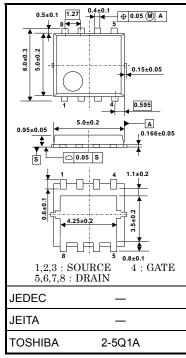
- Small footprint due to small and thin package •
- High-speed switching
- Small gate charge: Qsw = 6.6 nC (typ.) •
- Low drain-source ON resistance:  $R_{DS}$  (ON) = 16 m $\Omega$  (typ.) .
- High forward transfer admittance:  $|Y_{fs}| = 40 \text{ S}$  (typ.) .
- Low leakage current:  $I_{DSS} = 10 \ \mu A (max) (V_{DS} = 60 \ V)$
- Enhancement mode:  $V_{th}$  = 1.1 to 2.3 V ( $V_{DS}$  = 10 V,  $I_D$  = 1 mA)

#### Maximum Ratings (Ta = 25°C)

Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage	ource voltage		60	V	
Drain-gate voltage (R	R <sub>GS</sub> = 20 kΩ)	V <sub>DGR</sub>	60	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	۱ <sub>D</sub>	25	Α	
Diamounent	Pulsed (Note 1)	I <sub>DP</sub>	75	A	
Drain power dissipati	on (Tc = 25°C)	PD	45	W	
Drain power dissipati	on (t = 10 s) (Note 2a)	PD	2.8	W	
Drain power dissipation (t = 10 s) (Note 2b)		PD	1.6	W	
Single pulse avalanche energy (Note 3)		E <sub>AS</sub>	45	mJ	
Avalanche current		I <sub>AR</sub>	25	А	
Repetitive avalanche (1	energy 「c=25°C) (Note 4)	E <sub>AR</sub>	2.7	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	Storage temperature range		-55 to 150	°C	

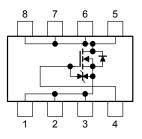
Note: For Notes 1to 5, refer to the next page.

This transistor is an electrostatic-sensitive device. Handle with caution.



Weight: 0.080 g (typ.)

#### **Circuit Configuration**

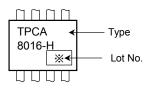


Unit: mm

### **Thermal Characteristics**

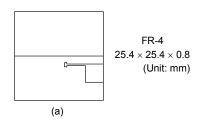
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case (Tc=25°C)	R <sub>th (ch-c)</sub>	2.78	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	44.6	°C/W
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2b)	R <sub>th (ch-a)</sub>	78.1	°C/W

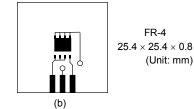
### Marking (Note 5)



Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)





(b) Device mounted on a glass-epoxy board (b)

Note 3:  $V_{DD} = 24 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$  (initial), L = 0.1 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = 25 A

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: \* Weekly code: (Three digits)



Week of manufacture

\_(01 for the first week of the year, continuing up to 52 or 53)

Year of manufacture
(The last digit of the year)

# **Electrical Characteristics (Ta = 25°C)**

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I <sub>GSS</sub>	$V_{GS} = \pm 16 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	_	—	±10	μA
Drain cut-OFF cu	rrent	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$	_	_	10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	60	_	_	v
Dialit-Source brea	akuowii voltage	V (BR) DSX			_	v	
Gate threshold vo	oltage	V <sub>th</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.1	_	2.3	V
	rogiatanag	Dec (cu)	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 13 \text{ A}$	_	16	21	
Drain-source ON	resistance	RDS (ON)	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 13 \text{ A}$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	mΩ		
Forward transfer	admittance	Y <sub>fs</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 13 \text{ A}$	20 40 —		S	
Input capacitance	,	C <sub>iss</sub>		_	1375	_	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	70	_	pF
Output capacitance		C <sub>oss</sub>			340		
		Rg			1.0		Ω
$\begin{array}{c c} \mbox{Drain-source ON resistance} & R_{DS} (0N) & \hline V_{GS} = 10 \\ \hline V_{GS} = 4. \\ \hline V_{OS} = 4. \\ \hline V_{DS} = 10 \\ \hline V$	Rise time	tr	10 V 🗖 🛛 lp = 13 A		4		
	$V_{GS} \stackrel{10}{_{0}} V \prod I_{D} = 13 \text{ A}$		10	_			
	Fall time	t <sub>f</sub>	R 0 1 44.7 0 R 0 1 44.7 0 =2.35 [ ↓ 1 1 0 0		3	_	- ns
	Turn-OFF time	t <sub>off</sub>	$V_{DD}\simeq 30~V \label{eq:VDD}$ Duty $\leq$ 1%, $t_W=10~\mu s$		19		
Total gate charge		0	$V_{DD}\simeq 48~V,~V_{GS}=10~V,~I_D=25~A$		22		
		Qg	$V_{DD}\simeq 48~V,~V_{GS}=5~V,~I_D=25~A$	5A 12		_	
Gate-source charge 1		Q <sub>gs1</sub>	$V_{DD} \simeq 48$ V, $V_{GS} = 10$ V, $I_D = 25$ A	_	4.6	_	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>		_	4.2	_	
Gate switch charg	је	Q <sub>SW</sub>		_	6.6	_	

## Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	I <sub>DRP</sub>	_	_	_	75	А
Forward voltage (diode)			V <sub>DSF</sub>	$I_{DR}=25~\text{A},~V_{GS}=0~\text{V}$	_		-1.2	V

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